

TOSHIBA INSULATED GATE BIPOLAR TRANSISTOR SILICON N CHANNEL IGBT

GT50G321

THE 4TH GENERATION

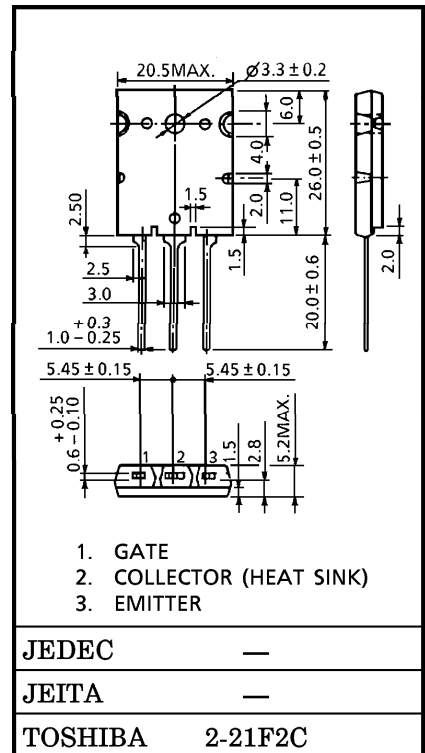
CURRENT RESONANCE INVERTER SWITCHING APPLICATIONS

- FRD Included Between Emitter and Collector
- Enhancement-Mode
- High Speed : $t_f = 0.30 \mu s$ (Typ.) ($I_C = 60 A$)
- Low Saturation Voltage : $V_{CE(sat)} = 1.8 V$ (Typ.) ($I_C = 60 A$)

MAXIMUM RATINGS ($T_a = 25^\circ C$)

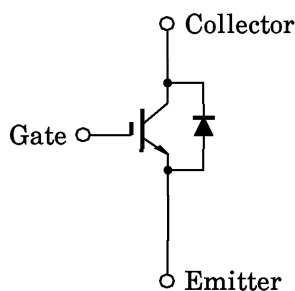
CHARACTERISTIC		SYMBOL	RATING	UNIT
Collector-Emitter Voltage		V_{CES}	400	V
Gate-Emitter Voltage		V_{GES}	± 25	V
Collector Current	DC	I_C	50	A
	1 ms	I_{CP}	100	
Emitter-Collector Forward Current	DC	I_F	15	A
	1 ms	I_{FP}	30	
Collector Power Dissipation ($T_c = 25^\circ C$)		P_C	130	W
Junction Temperature		T_j	150	$^\circ C$
Storage Temperature Range		T_{stg}	-55~150	$^\circ C$

Unit in mm



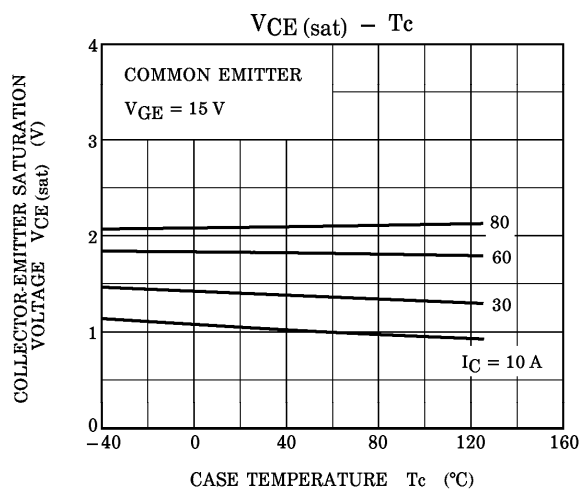
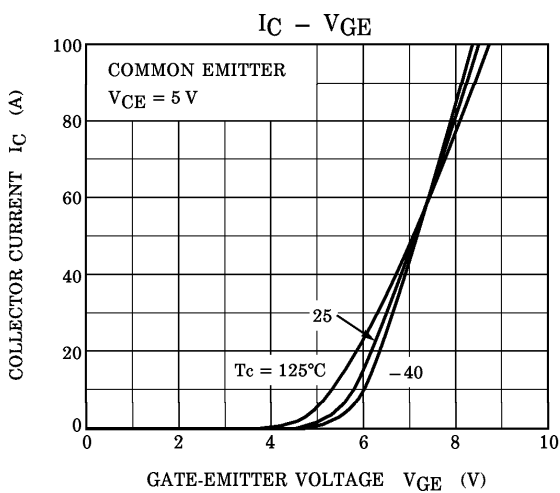
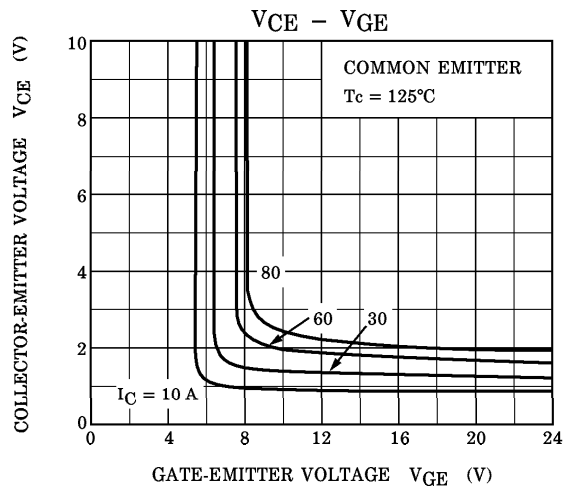
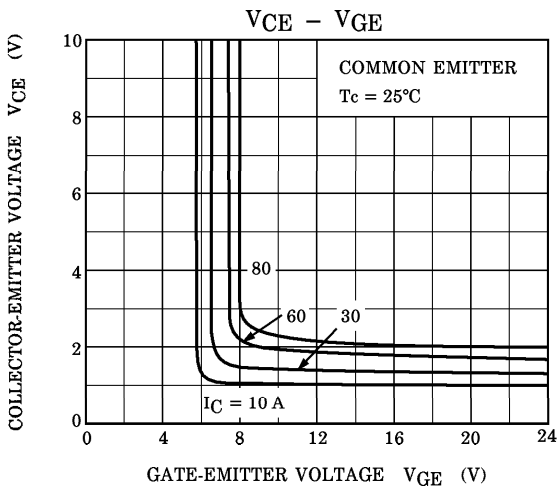
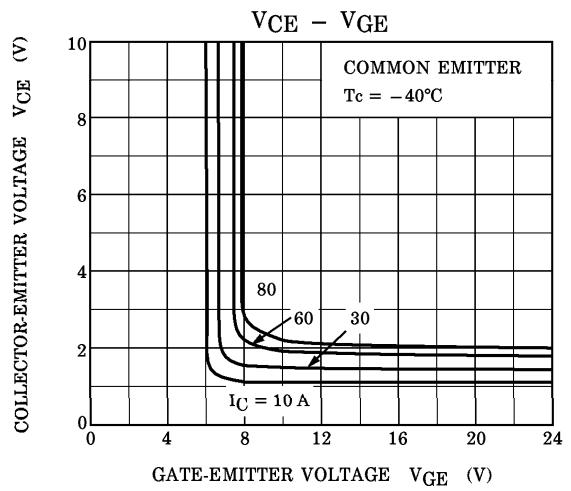
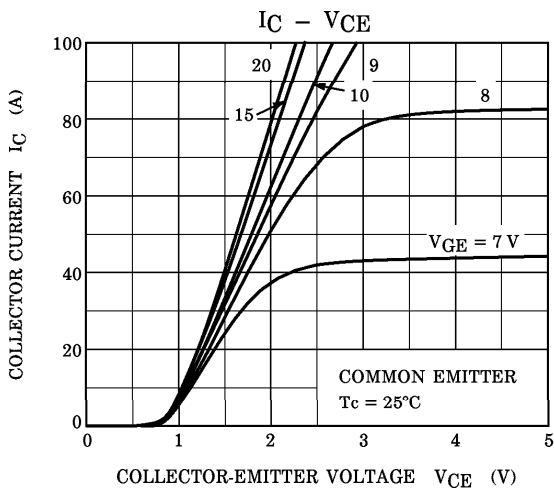
Weight : 9.75 g

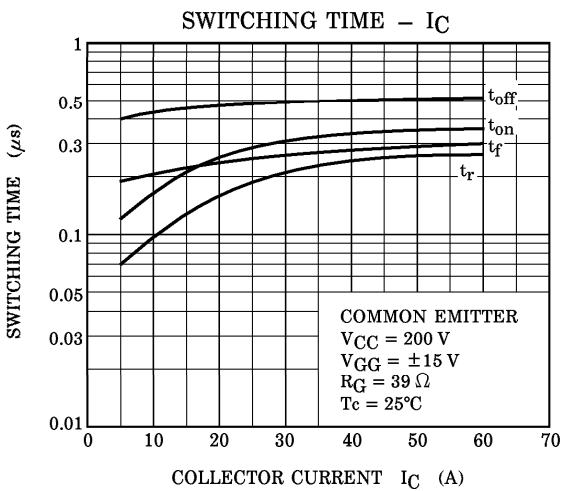
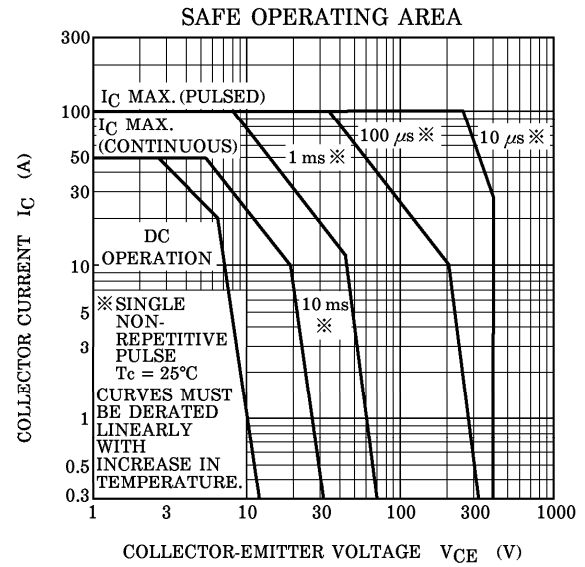
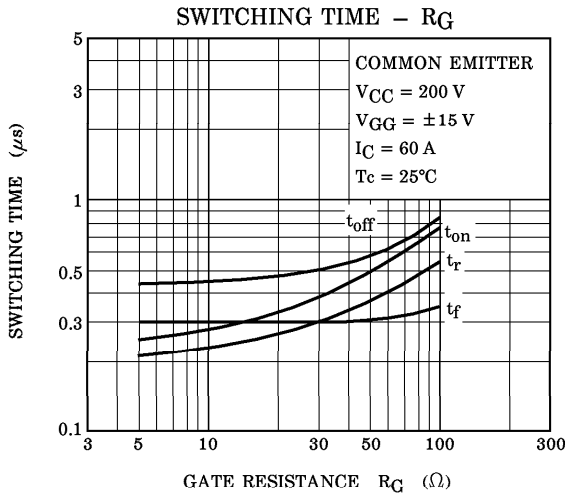
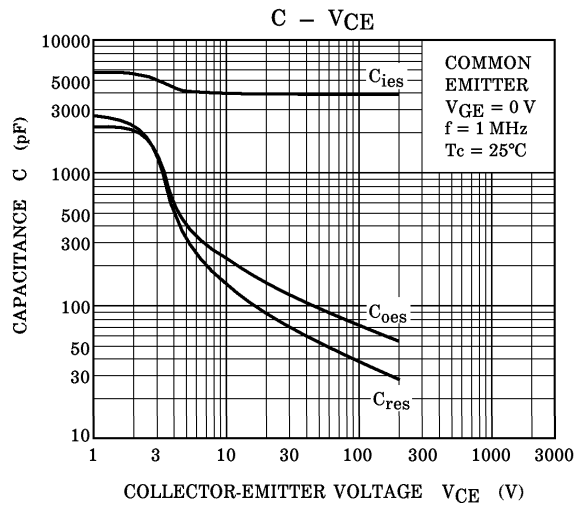
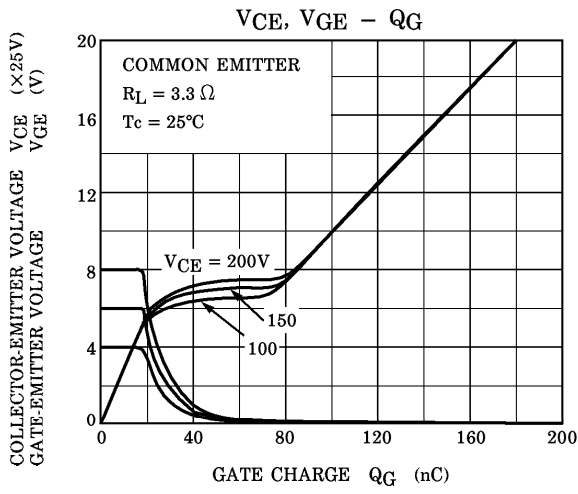
EQUIVALENT CIRCUIT

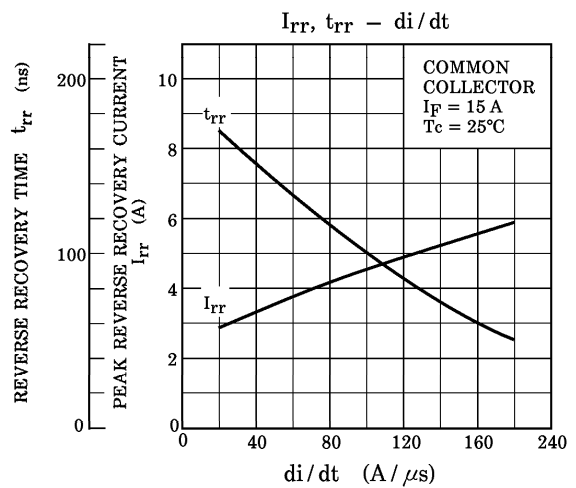
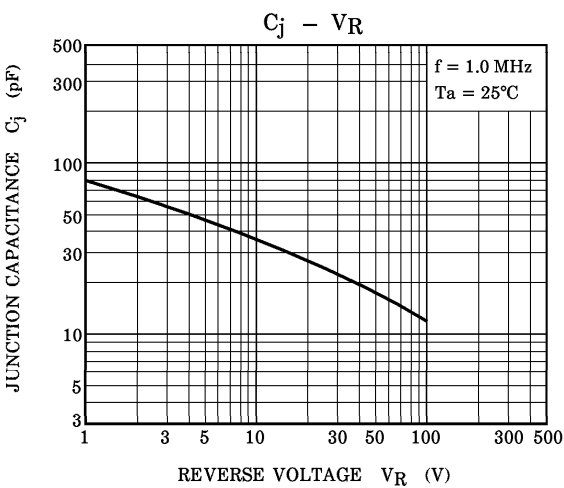
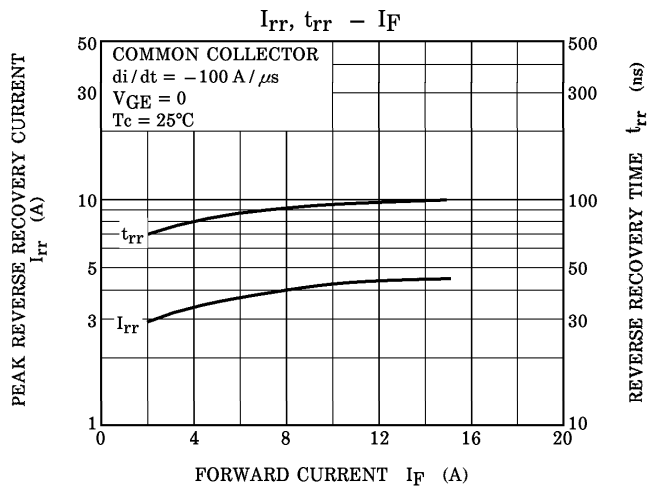
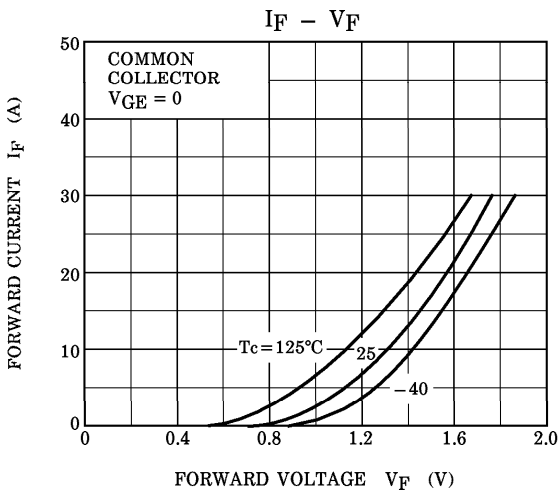
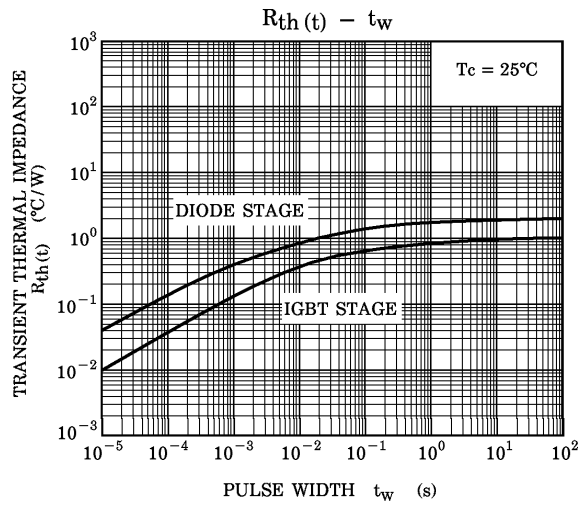
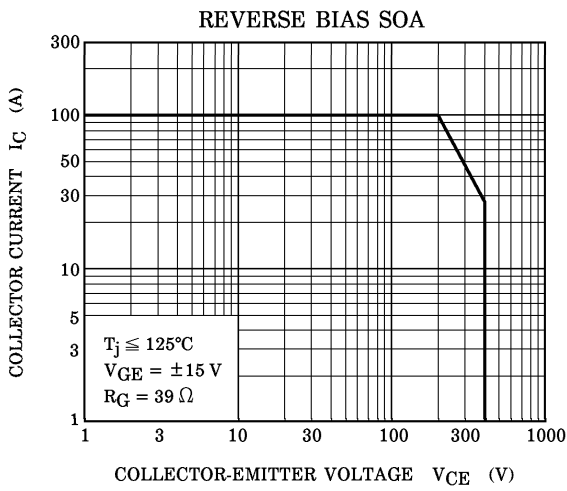


ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC		SYMBOL	TEST CONDITION	MIN.	TYP	MAX.	UNIT
Gate Leakage Current		I _{GES}	V _{GE} = ±25 V, V _{CE} = 0	—	—	±500	nA
Collector Cut-off Current		I _{CES}	V _{CE} = 400 V, V _{GE} = 0	—	—	1.0	mA
Gate-Emitter Cut-off Voltage		V _{GE (OFF)}	I _C = 60 mA, V _{CE} = 5 V	3.0	—	6.0	V
Collector-Emitter Saturation Voltage		V _{CE (sat)}	I _C = 60 A, V _{GE} = 15 V	—	1.8	2.5	V
Input Capacitance		C _{ies}	V _{CE} = 10 V, V _{GE} = 0, f = 1 MHz	—	3900	—	pF
Switching Time	Rise Time	t _r		—	0.33	—	μs
	Turn-on Time	t _{on}		—	0.43	—	
	Fall Time	t _f		—	0.30	0.40	
	Turn-off Time	t _{off}		—	0.54	—	
Forward Voltage		V _F	I _F = 15 A, V _{GE} = 0	—	—	2.0	V
Reverse Recovery Time		t _{rr}	I _F = 15 A, V _{GE} = 0 di / dt = -100 A / μs	—	—	0.2	μs
Thermal Resistance		R _{th (j-c)}	IGBT	—	—	0.96	°C / W
Thermal Resistance		R _{th (j-e)}	Diode	—	—	2.08	°C / W







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